

Notice of References Cited

Application/Control No.

10/567,001

Applicant(s)/Patent Under
Reexamination
HAN ET AL.

Examiner

JOSHUA SMITH

Art Unit

2419

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,038,592 A	03-2000	Verplanken et al.	370/390
*	B	US-2002/0093960 A1	07-2002	Tsuchiya et al.	370/390
*	C	US-2002/0154634 A1	10-2002	Basso et al.	370/390
*	D	US-2003/0076828 A1	04-2003	Henrion, Michel	370/390
*	E	US-2004/0095934 A1	05-2004	Cheng et al.	370/390
*	F	US-2004/0114616 A1	06-2004	Wang, Linghsiao	370/412
*	G	US-2004/0202163 A1	10-2004	Lee, Jong Ick	370/390
*	H	US-6,873,627 B1	03-2005	Miller et al.	370/466
*	I	US-2005/0111452 A1	05-2005	Mamillapalli et al.	370/390
*	J	US-2005/0213545 A1	09-2005	Choyi et al.	370/338
*	K	US-7,079,501 B2	07-2006	Boivie, Richard H.	370/312
*	L	US-7,280,542 B2	10-2007	Hassan-Ali et al.	370/390
*	M	US-7,397,809 B2	07-2008	Wang, Linghsiao	370/390

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(e).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.